Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/619,162	HAYDEN ET AL.		
Examiner	Art Unit		
Harold Kim	2182		

					
SEARCHED					
Class	Subclass	Date	Examiner		
710	5, 29, 36, 7, 52, 100, 118	12/11/2005	нк		
711	138, 225	12/11/2005	нк		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
USPAT, USPBPUB, JPO, EPO, IEEE, NPL, see attached search note, inventor search on eDAN	12/11/2005	нк		
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